Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/849,003	HARBIN, EDWARD ALTON
Examiner	Art Unit
Dienane M. Bayard	2141

	SEARCHED				
Class	Subclass	Date	Examiner		
709	251	11/2/2005	DB		
709	238	11/2/2005	DB		
709	249	11/2/2005			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
709	251	11/2/2005	DB		
709	238	11/2/2005	DB		
709	249	11/2/2005	DB		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
East	11/2/2005	DB
NPL (google scholar, IEEESafari Books Oline)	11/2/2005	DB
Inventor's search	11/2/2005	DB